

# Search Notes



Application No.

09/817,225

Examiner

Tan Dean D. Nguyen

Applicant(s)

AZUMA, NOBUHIRO

Art Unit

3629

## SEARCHED

| Class | Subclass | Date    | Examiner |
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| 705   | 1        | 7/30/04 | SN       |
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## INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

|                   | DATE    | EXMR |
|-------------------|---------|------|
| US Patent, PG Pub | 7/30/04 | SN   |
| Foreign           |         |      |
| EPO               |         |      |
| JPO               |         |      |
| Derwent           |         |      |
| NPL (Inalog)      |         |      |
| 1. Fkxt           |         |      |
| 2. Fkxt2          |         |      |
| 3. NFkxt          |         |      |
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